

**Notice of References Cited**

Application/Control No.

10/049,767

Applicant(s)/Patent Under  
Reexamination  
BANNAI ET AL.

Examiner

Michael Barr

Art Unit

1762

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,478,860	11-2002	Nakayama et al.	106/14.05
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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